

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/743,787	MAEDA, TOSHIHIRO
	Examiner	Art Unit
	MICHAEL Y. WON	2455

**SEARCHED**

## INTERFERENCE SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**